COMBINATIONAL vs. SEQUENTIAL

**Combinational**
\[ y = f(\text{inputs}) \]
- \( n \) inputs, \( m \) outputs

Examples:
- Adder: \( y[0:3] = a[0:3] + b[0:3] \)
- memoryless systems

**Sequential**
\[ y = f(\text{inputs, time}) \]
- (most useful: clocked logic)

Example: (down) counter

<table>
<thead>
<tr>
<th>Time (e.g. sec)</th>
<th>( Y[0:3] )</th>
</tr>
</thead>
<tbody>
<tr>
<td>0 ( 10_{10} )</td>
<td>0</td>
</tr>
<tr>
<td>1</td>
<td>9</td>
</tr>
<tr>
<td>2</td>
<td>8</td>
</tr>
<tr>
<td>...</td>
<td>...</td>
</tr>
<tr>
<td>10( _{10} )</td>
<td>0</td>
</tr>
</tbody>
</table>

![Diagram of down counter]
ALGORITHMS IN HW

Example: Finding the largest number in a list.
Unsigned int a[1024]; 32 bit int

Approach #1: Combinational
Number of input variables? 32768
Number of lines in truth table? $2^{32768}$

<table>
<thead>
<tr>
<th>a</th>
<th>logic</th>
<th>32 bits</th>
<th>Biggest #</th>
</tr>
</thead>
<tbody>
<tr>
<td>32 bit #s</td>
<td>32768 inputs</td>
<td>bit 0</td>
<td>3 gate delays</td>
</tr>
</tbody>
</table>

time delay? (S.O.P.)

Approach #2: Combinational – divide & conquer
Each MAX block has: 64 inputs; 32 outputs
$2^{64}$ entries in truth table
Delay = ? $3 \times 10 = 30$ units

512 + 256 + ... + 1 = 1023 blocks
ALGORITHMS IN HW

Approach #3: Sequential

max = 0;
for (i=0; i<32768, i++)
    if (a[i]>max) max=a[i];

Hardware equivalence:
- \( a[i] \rightarrow 1024 \times 32 \text{ bit memory} \)
- for \((i=0; i<1024; i++) \rightarrow 15 \text{ bit counter} \)
- if \( \text{(a[i]}>\text{max}) \rightarrow \text{“comparator” (combinational)} \)
- max=a[i] \rightarrow \text{register}

Sequential Circuits

- Circuits with Feedback
  - Outputs = f(inputs, past inputs, past outputs)
  - Basis for building "memory" into logic circuits
  - Door combination lock is an example of a sequential circuit
    - State is memory
    - State is an "output" and an "input" to combinational logic
    - Combination storage elements are also memory

Simplest Circuits with Feedback

- Two inverters form a static memory cell
  - Will hold value as long as it has power applied

![Diagram of two inverters forming a memory cell]

- How to get a new value into the memory cell?
  - Selectively break feedback path
  - Load new value into cell

Memory with Cross-coupled Gates

- Cross-coupled NOR gates
  - Similar to inverter pair, with capability to force output to 0 (reset=1) or 1 (set=1)

![Diagram of cross-coupled NOR gates]

- Cross-coupled NAND gates
  - Similar to inverter pair, with capability to force output to 0 (reset=0) or 1 (set=0)

![Diagram of cross-coupled NAND gates]
Timing Behavior

R-S Latch Behavior

- State Diagram
  - States: possible values
  - Transitions: changes based on inputs

possible oscillation between states 00 and 11
Observed R-S Latch Behavior

- Very difficult to observe R-S latch in the 1-1 state
  - One of R or S usually changes first
- Ambiguously returns to state 0-1 or 1-0
  - A so-called "race condition"
  - Or non-deterministic transition

Gated R-S Latch

- Control when R and S inputs matter
- Otherwise, the slightest glitch on R or S while enable is low could cause change in value stored
Clocks

- Used to keep time
  - Wait long enough for inputs (R' and S') to settle
  - Then allow to have effect on value stored
- Clocks are regular periodic signals
  - Period (time between ticks)
  - Duty-cycle (time clock is high between ticks - expressed as % of period)

![Duty cycle and period diagram]

Clocks (cont’d)

- Controlling an R-S latch with a clock
  - Can't let R and S change while clock is active (allowing R and S to pass)
  - Only have half of clock period for signal changes to propagate
  - Signals must be stable for the other half of clock period

![R-S latch diagram with clock signals]
Cascading Latches

- Connect output of one latch to input of another
- How to stop changes from racing through chain?
  - Need to control flow of data from one latch to the next
  - Advance from one latch per clock period
  - Worry about logic between latches (arrows) that is too fast

Master-Slave Structure

- Break flow by alternating clocks (like an air-lock)
  - Use positive clock to latch inputs into one R-S latch
  - Use negative clock to change outputs with another R-S latch
- View pair as one basic unit
  - master-slave flip-flop
  - twice as much logic
  - output changes a few gate delays after the falling edge of clock but does not affect any cascaded flip-flops
### D Flip-Flop

- Make S and R complements of each other
  - Eliminates 1s catching problem
  - Can't just hold previous value (must have new value ready every clock period)
  - Value of D just before clock goes low is what is stored in flip-flop
  - Can make R-S flip-flop by adding logic to make $D = S + R'$

![D Flip-Flop Diagram](image)

- 10 gates

### Edge-Triggered Flip-Flops

- More efficient solution: only 6 gates
  - Sensitive to inputs only near edge of clock signal (not while high)

![Edge-Triggered Flip-Flop Diagram](image)

- Negative edge-triggered D flip-flop (D-FF)
  - 4-5 gate delays
  - Must respect setup and hold time constraints to successfully capture input
  - Characteristic equation: $Q(t+1) = D$
Edge-Triggered Flip-Flops

- Positive edge-triggered
  - Inputs sampled on rising edge; outputs change after rising edge
- Negative edge-triggered flip-flops
  - Inputs sampled on falling edge; outputs change after falling edge

Timing Methodologies

- Rules for interconnecting components and clocks
  - Guarantee proper operation of system when strictly followed
- Approach depends on building blocks used for memory elements
  - Focus on systems with edge-triggered flip-flops
    - Found in programmable logic devices
  - Many custom integrated circuits focus on level-sensitive latches
- Basic rules for correct timing:
  - (1) Correct inputs, with respect to time, are provided to the flip-flops
  - (2) No flip-flop changes state more than once per clocking event
Timing Methodologies (cont’d)

- Definition of terms
  - clock: periodic event, causes state of memory element to change; can be rising or falling edge, or high or low level
  - setup time: minimum time before the clocking event by which the input must be stable (Tsu)
  - hold time: minimum time after the clocking event until which the input must remain stable (Th)

Comparison of Latches & Flip-Flops

- Positive edge-triggered flip-flop
- Transparent (level-sensitive) latch

Behavior is the same unless input changes while the clock is high.
### Comparison of Latches & Flip-Flops

<table>
<thead>
<tr>
<th>Type</th>
<th>When inputs are sampled</th>
<th>When output is valid</th>
</tr>
</thead>
<tbody>
<tr>
<td>unclocked latch</td>
<td>always</td>
<td>propagation delay from input change</td>
</tr>
<tr>
<td>level-sensitive latch</td>
<td>clock high (Tsu/Th around falling edge of clock)</td>
<td>propagation delay from input change or clock edge (whichever is later)</td>
</tr>
<tr>
<td>master-slave flip-flop</td>
<td>clock high (Tsu/Th around falling edge of clock)</td>
<td>propagation delay from falling edge of clock</td>
</tr>
<tr>
<td>negative edge-triggered flip-flop</td>
<td>clock hi-to-lo transition (Tsu/Th around falling edge of clock)</td>
<td>propagation delay from falling edge of clock</td>
</tr>
</tbody>
</table>

### Cascading Edge-triggered FFs

- **Shift register**
  - New value goes into first stage
  - While previous value of first stage goes into second stage
  - Consider setup/hold/propagation delays (prop must be > hold)

[Diagram of cascading edge-triggered FFs]
### Metastability: Asynchronous inputs

- **Clocked synchronous circuits**
  - Inputs, state, and outputs sampled or changed in relation to a common reference signal (called the clock)
  - E.g., master/slave, edge-triggered

- **Asynchronous circuits**
  - Inputs, state, and outputs sampled or changed independently of a common reference signal (glitches/hazards a major concern)
  - E.g., R-S latch

- **Asynchronous inputs to synchronous circuits**
  - Inputs can change at any time, will not meet setup/hold times
  - Dangerous, synchronous inputs are greatly preferred
  - Cannot be avoided (e.g., reset signal, memory wait, user input)

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### Correcting Synchronization Failure

- Probability of failure can never be reduced to 0, but it can be reduced
  - (1) slow down the system clock: this gives the synchronizer more time to decay into a steady state; synchronizer failure becomes a big problem for very high speed systems
  - (2) use fastest possible logic technology in the synchronizer: this makes for a very sharp "peak" upon which to balance
  - (3) cascade two synchronizers: this effectively synchronizes twice (both would have to fail)
Handling Asynchronous Inputs

- Never allow asynchronous inputs to fan-out to more than one flip-flop
  - Synchronize as soon as possible and then treat as synchronous signal

handling Asynchronous Inputs

- What can go wrong?
  - Input changes too close to clock edge (violating setup time constraint)

In is asynchronous and fans out to D0 and D1
one FF catches the signal, one does not
inconsistent state may be reached!
Flip-Flop Features

- Reset (set state to 0) – R
  - Synchronous: $D_{new} = R' \cdot D_{old}$ (when next clock edge arrives)
  - Asynchronous: doesn't wait for clock, quick but dangerous
- Preset or set (set state to 1) – S (or sometimes P)
  - Synchronous: $D_{new} = D_{old} + S$ (when next clock edge arrives)
  - Asynchronous: doesn't wait for clock, quick but dangerous
- Both reset and preset
  - $D_{new} = R' \cdot D_{old} + S$ (set-dominant)
  - $D_{new} = R' \cdot D_{old} + R'S$ (reset-dominant)
- Selective input capability (input enable/load) – LD or EN
  - Multiplexer at input: $D_{new} = LD' \cdot Q + LD \cdot D_{old}$
  - Load may/may not override reset/set (usually R/S have priority)
- Complementary outputs – $Q$ and $Q'$

Registers

- Collections of flip-flops with similar controls and logic
  - Stored values somehow related (e.g., form binary value)
  - Share clock, reset, and set lines
  - Similar logic at each stage
- Examples
  - Shift registers
  - Counters
Shift Register

- Holds samples of input
  - Store last 4 input values in sequence
  - 4-bit shift register:

```
+-----+       +-----+       +-----+       +-----+     
| IN  |       | D Q  |       | D Q  |       | D Q  |       | D Q  |
| CLK |       |      |       |      |       |      |       |      |
```

- Universal Shift Register

- Holds 4 values
  - Serial or parallel inputs
  - Serial or parallel outputs
  - Permits shift left or right
  - Shift in new values from left or right

```
+-----+     +-----+     +-----+     +-----+     +-----+ 
| left_in | right_out | left_out | right_in | clear | s1 | s0 |
+-----+     +-----+     +-----+     +-----+     +-----+ 
|      |       |      |       |       |    |    |
|      |       |      |       |       |    |    |
|      |       |      |       |       |    |    |
|      |       |      |       |       |    |    |
|      |       |      |       |       |    |    |
```

- clears the register contents and output to 0
- s1 and s0 determine the shift function

<table>
<thead>
<tr>
<th>s0</th>
<th>s1</th>
<th>function</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>hold state</td>
</tr>
<tr>
<td>0</td>
<td>1</td>
<td>shift right</td>
</tr>
<tr>
<td>1</td>
<td>0</td>
<td>shift left</td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>load new input</td>
</tr>
</tbody>
</table>
Counters

- Sequences through a fixed set of patterns
  - In this case, 1000, 0100, 0010, 0001
  - If one of the patterns is its initial state (by loading or set/reset)

- Mobius (or Johnson) counter
  - In this case, 1000, 1100, 1110, 1111, 0111, 0011, 0001, 0000

Binary Counter

- Logic between registers (not just multiplexer)
  - XOR decides when bit should be toggled
  - Always for low-order bit, only when first bit is true for second bit, and so on
4-bit Synchronous Up-Counter

- Standard component with many applications
  - Positive edge-triggered FFs w/ sync load and clear inputs
  - Parallel load data from D, C, B, A
  - Enable inputs: must be asserted to enable counting
  - RCO: ripple-carry out used for cascading counters
    - high when counter is in its highest state 1111
    - implemented using an AND gate

[Diagram showing count up from 0 to 15 with labels for D, C, B, A, RCO, LOAD, CLK, CLR]

- (1) Low order 4-bits = 1111
- (2) RCO goes high
- (3) High order 4-bits are incremented